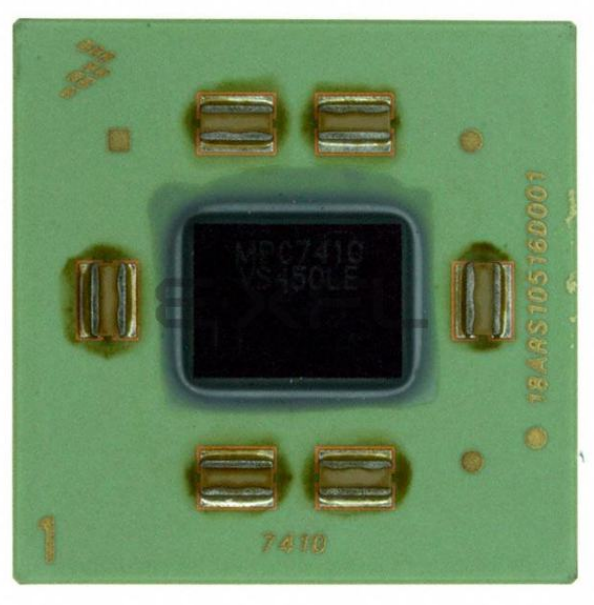

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Understanding Embedded - Microprocessors

Embedded microprocessors are specialized computing chips designed to perform specific tasks within an embedded system. Unlike general-purpose microprocessors found in personal computers, embedded microprocessors are tailored for dedicated functions within larger systems, offering optimized performance, efficiency, and reliability. These microprocessors are integral to the operation of countless electronic devices, providing the computational power necessary for controlling processes, handling data, and managing communications.

Applications of Embedded - Microprocessors

Embedded microprocessors are utilized across a broad spectrum of applications, making them indispensable in

Details	
Product Status	Obsolete
Core Processor	PowerPC G4
Number of Cores/Bus Width	1 Core, 32-Bit
Speed	400MHz
Co-Processors/DSP	-
RAM Controllers	-
Graphics Acceleration	No
Display & Interface Controllers	-
Ethernet	-
SATA	-
USB	-
Voltage - I/O	1.8V, 2.5V, 3.3V
Operating Temperature	0°C ~ 105°C (TA)
Security Features	-
Package / Case	360-CLGA, FCCLGA
Supplier Device Package	360-FCCLGA (25x25)
Purchase URL	https://www.e-xfl.com/pro/item?MUrl=&PartUrl=mpc7410vs400le

- The MPC7410 is implemented in a next generation process technology for core frequency improvement.
- The MPC7410 floating-point unit has been improved to make latency equal for double- and single-precision operations involving multiplication.
- The completion queue has been extended to eight slots.
- There are no other significant changes to scalar pipelines, decode/dispatch/completion mechanisms, or the branch unit. The MPC750 four-stage pipeline model is unchanged (fetch, decode/dispatch, execute, complete/writeback).

Some comments on the MPC7410 with respect to the MPC7400:

- The MPC7410 adds configurable direct-mapped SRAM capability to the L2 cache interface.
- The MPC7410 adds 32-bit interface support to the L2 cache interface. The MPC7410 implements a 19th L2 address pin (L2ASPARE on the MPC7400) in order to support additional address range.
- The MPC7410 removes support for 3.3-V I/O on the L2 cache interface.

Figure 1 shows a block diagram of the MPC7410.

2 Features

This section summarizes features of the MPC7410 implementation of the PowerPC architecture. Major features of the MPC7410 are as follows:

- Branch processing unit
  - Four instructions fetched per clock
  - One branch processed per cycle (plus resolving two speculations)
  - Up to one speculative stream in execution, one additional speculative stream in fetch
  - 512-entry branch history table (BHT) for dynamic prediction
  - 64-entry, four-way set-associative branch target instruction cache (BTIC) for eliminating branch delay slots
- Dispatch unit
  - Full hardware detection of dependencies (resolved in the execution units)
  - Dispatch two instructions to eight independent units (system, branch, load/store, fixed-point unit 1, fixed-point unit 2, floating-point, AltiVec permute, AltiVec ALU)
  - Serialization control (predispatch, postdispatch, execution serialization)

- Decode
  - Register file access
  - Forwarding control
  - Partial instruction decode
- Completion
  - Eight-entry completion buffer
  - Instruction tracking and peak completion of two instructions per cycle
  - Completion of instructions in program order while supporting out-of-order instruction execution, completion serialization, and all instruction flow changes
- Fixed point units (FXUs) that share 32 GPRs for integer operands
  - Fixed point unit 1 (FXU1)—multiply, divide, shift, rotate, arithmetic, logical
  - Fixed point unit 2 (FXU2)—shift, rotate, arithmetic, logical
  - Single-cycle arithmetic, shifts, rotates, logical
  - Multiply and divide support (multi-cycle)
  - Early out multiply
- Three-stage floating-point unit and a 32-entry FPR file
  - Support for IEEE Std 754™ single- and double-precision floating-point arithmetic
  - Three-cycle latency, one-cycle throughput (single- or double-precision)
  - Hardware support for divide
  - Hardware support for denormalized numbers
  - Time deterministic non-IEEE mode
- System unit
  - Executes CR logical instructions and miscellaneous system instructions
  - Special register transfer instructions
- AltiVec unit
  - Full 128-bit data paths
  - Two dispatchable units: vector permute unit and vector ALU unit.
  - Contains its own 32-entry, 128-bit vector register file (VRF) with 6 renames
  - The vector ALU unit is further subdivided into the vector simple integer unit (VSIU), the vector complex integer unit (VCIU), and the vector floating-point unit (VFPU).
  - Fully pipelined
- Load/store unit
  - One-cycle load or store cache access (byte, half word, word, double word)
  - Two-cycle load latency with 1-cycle throughput
  - Effective address generation
  - Hits under misses (multiple outstanding misses)
  - Single-cycle unaligned access within double-word boundary
  - Alignment, zero padding, sign extend for integer register file
  - Floating-point internal format conversion (alignment, normalization)
  - Sequencing for load/store multiples and string operations

  - Store gathering
  - Executes the cache and TLB instructions
  - Big- and little-endian byte addressing supported
  - Misaligned little-endian supported
  - Supports FXU, FPU, and AltiVec load/store traffic
  - Complete support for all four architecture AltiVec DST streams
- Level 1 (L1) cache structure
  - 32 Kbyte, 32-byte line, eight-way set-associative instruction cache (iL1)
  - 32 Kbyte, 32-byte line, eight-way set-associative data cache (dL1)
  - Single-cycle cache access
  - Pseudo least-recently-used (LRU) replacement
  - Data cache supports AltiVec LRU and transient instructions algorithm
  - Copy-back or write-through data cache (on a page-per-page basis)
  - Supports all PowerPC memory coherency modes
  - Nonblocking instruction and data cache
  - Separate copy of data cache tags for efficient snooping
  - No snooping of instruction cache except for ICBI instruction
- Level 2 (L2) cache interface
  - Internal L2 cache controller and tags; external data SRAMs
  - 512-Kbyte, 1-Mbyte, and 2-Mbyte two-way set-associative L2 cache support
  - Copy-back or write-through data cache (on a page basis, or for all L2)
  - 32-byte (512-Kbyte), 64-byte (1-Mbyte), or 128-byte (2-Mbyte) sectored line size
  - Supports pipelined (register-register) synchronous BurstRAMs and pipelined (register-register) late write synchronous BurstRAMs
  - Supports direct-mapped mode for 256 Kbytes, 512 Kbytes, 1 Mbyte, or 2 Mbytes of SRAM (either all, half, or none of L2 SRAM must be configured as direct-mapped)
  - Core-to-L2 frequency divisors of ÷1, ÷1.5, ÷2, ÷2.5, ÷3, ÷3.5, and ÷4 supported
  - 64-bit data bus which also supports 32-bit bus mode
  - Selectable interface voltages of 1.8 and 2.5 V
- Memory management unit
  - 128-entry, two-way set-associative instruction TLB
  - 128-entry, two-way set-associative data TLB
  - Hardware reload for TLBs
  - Four instruction BATs and four data BATs
  - Virtual memory support for up to 4 hexabytes (2^{52}) of virtual memory
  - Real memory support for up to 4 gigabytes (2^{32}) of physical memory
  - Snooped and invalidated for TLBI instructions
- Efficient data flow
  - All data buses between VRF, load/store unit, dL1, iL1, L2, and the bus are 128 bits wide
  - dL1 is fully pipelined to provide 128 bits/cycle to/from the VRF

Table 1. Absolute Maximum Ratings [1] (continued)

Characteristic	Symbol	Maximum Value	Unit	Notes
Rework temperature	T_{rwk}	260	°C	—

Notes:
1. Functional and tested operating conditions are given in Table 3. Absolute maximum ratings are stress ratings only, and functional operation at the maximums is not guaranteed. Stresses beyond those listed may affect device reliability or cause permanent damage to the device.
2. **Caution**: V_{in} must not exceed OV_{DD} or $L2OV_{DD}$ by more than 0.2 V at any time including during power-on reset.
3. **Caution**: $L2OV_{DD}/OV_{DD}$ must not exceed $V_{DD}/AV_{DD}/L2AV_{DD}$ by more than 2.0 V at any time including during power-on reset; this limit may be exceeded for a maximum of 20 ms during power-on reset and power-down sequences.
4. **Caution**: $V_{DD}/AV_{DD}/L2AV_{DD}$ must not exceed $L2OV_{DD}/OV_{DD}$ by more than 0.4 V at any time including during power-on reset; this limit may be exceeded for a maximum of 20 ms during power-on reset and power-down sequences.
5. V_{in} may overshoot/undershoot to a voltage and for a maximum duration as shown in Figure 2.
6. M*xx*7410*xxnnn*LE (Rev. 1.4) and later only. Previous revisions do not support 3.3 V OV_{DD} and have a maximum value OV_{DD} of –0.3 to 2.8 V.

Figure 2 shows the allowable undershoot and overshoot voltage for the MPC7410.

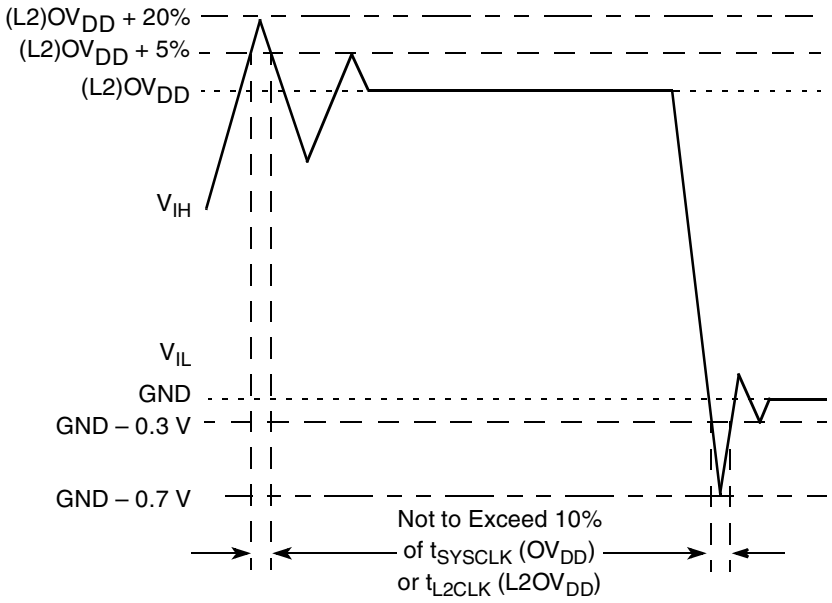

Figure 2. Overshoot/Undershoot Voltage

The MPC7410 provides several I/O voltages to support both compatibility with existing systems and migration to future systems. The MPC7410 core voltage must always be provided at nominal voltage (see Table 3 for actual recommended core voltage). Voltage to the L2 I/Os and processor interface I/Os are provided through separate sets of supply pins and may be provided at the voltages shown in Table 2. Voltage must be provided to the $L2OV_{DD}$ power pins even if the interface is not used. The input voltage threshold for each bus is selected by sampling the state of the voltage select pins BVSEL and L2VSEL at the negation of the signal $\overline{\text{HRESET}}$. These signals must remain stable during part operation and cannot change. The output voltage will swing from GND to the maximum voltage applied to the OV_{DD} or $L2OV_{DD}$ power pins.

Table 4. Package Thermal Characteristics (continued)

Characteristic	Symbol	Value		Unit	Notes
		MPC7410 CBGA	MPC7410 HCTE		
Junction-to-case thermal resistance	$R_{\theta JC}$	< 0.1	< 0.1	°C/W	4

Notes:

1. Junction temperature is a function of die size, on-chip power dissipation, package thermal resistance, mounting site (board) temperature, ambient temperature, air flow, power dissipation of other components on the board, and board thermal resistance.
2. Per JEDEC JESD51-6 with the board horizontal.
3. Thermal resistance between the die and the printed circuit board per JEDEC JESD51-8. Board temperature is measured on the top surface of the board near the package.
4. Thermal resistance between the active portion of the die and the calculated case temperature at the top of the die. The actual value of R JC is less than 0.1 °C/W.

Note: Refer to Section 8.8, "Thermal Management Information," for details on thermal management.

Table 5 provides the DC electrical characteristics for the MPC7410.

Table 5. DC Electrical Specifications

At recommended operating conditions (see Table 3)

Characteristic	Nominal Bus Voltage[1]	Symbol	Min	Max	Unit	Notes
Input high voltage (all inputs except SYSCLK)	1.8	V_{IH}	$0.65 \times (L2)OV_{DD}$	$(L2)OV_{DD} + 0.2$	V	2, 3, 8
	2.5	V_{IH}	1.7	$(L2)OV_{DD} + 0.2$		
	3.3	V_{IH}	2.0	$OV_{DD} + 0.3$		
Input low voltage (all inputs except SYSCLK)	1.8	V_{IL}	–0.3	$0.35 \times (L2)OV_{DD}$	V	8
	2.5	V_{IL}	–0.3	$0.2 \times (L2)OV_{DD}$		
	3.3	V_{IL}	–0.3	0.8		
SYSCLK input high voltage	1.8	CV_{IH}	1.5	$OV_{DD} + 0.2$	V	2, 8
	2.5	CV_{IH}	2.0	$OV_{DD} + 0.2$		
	3.3	CV_{IH}	2.4	$OV_{DD} + 0.3$		
SYSCLK input low voltage	1.8	CV_{IL}	–0.3	0.2	V	8
	2.5	CV_{IL}	–0.3	0.4		
	3.3	CV_{IL}	–0.3	0.4		
Input leakage current, $V_{in} = L2OV_{DD}/OV_{DD}$	1.8	I_{in}	—	20	µA	2, 3, 6, 7
	2.5	I_{in}	—	35		
	3.3	I_{in}	—	70		

Table 8. Processor Bus AC Timing Specifications [1] (continued)

At recommended operating conditions (see Table 3)

Parameter	Symbol [2]	400, 450, 500 MHz		Unit	Notes
		Min	Max		
SYSCLK to $\overline{\text{ARTRY}}$, $\overline{\text{SHD0}}$, $\overline{\text{SHD1}}$ high impedance after precharge	t_{KHARPZ}	—	2	t_{SYSCLK}	3, 8, 9

Notes:

1. All input specifications are measured from the midpoint of the signal in question to the midpoint of the rising edge of the input SYSCLK. All output specifications are measured from the midpoint of the rising edge of SYSCLK to the midpoint of the signal in question. All output timings assume a purely resistive 50-Ω load (see Figure 4). Input and output timings are measured at the pin; time-of-flight delays must be added for trace lengths, vias, and connectors in the system.
2. The symbology used for timing specifications herein follows the pattern of $t_{\text{(signal)(state)(reference)(state)}}$ for inputs and $t_{\text{(reference)(state)(signal)(state)}}$ for outputs. For example, t_{IVKH} symbolizes the time input signals (I) reach the valid state (V) relative to the SYSCLK reference (K) going to the high (H) state or input setup time. And t_{KHOV} symbolizes the time from SYSCLK(K) going high (H) until outputs (O) are valid (V) or output valid time. Input hold time can be read as the time that the input signal (I) went invalid (X) with respect to the rising clock edge (KH)— note the position of the reference and its state for inputs—and output hold time can be read as the time from the rising edge (KH) until the output went invalid (OX).
3. t_{SYSCLK} is the period of the external clock (SYSCLK) in ns. The numbers given in the table must be multiplied by the period of SYSCLK to compute the actual time duration (in ns) of the parameter in question.
4. Includes mode select signals: BVSEL, EMODE, L2VSEL. See Figure 5 for mode select timing with respect to $\overline{\text{HRESET}}$.
5. All other output signals are composed of the following— A[0:31], AP[0:3], TT[0:4], TS, $\overline{\text{TBST}}$, TSIZ[0:2], $\overline{\text{GBL}}$, $\overline{\text{WT}}$, $\overline{\text{CI}}$, DH[0:31], DL[0:31], DP[0:7], $\overline{\text{BR}}$, $\overline{\text{CKSTP\_OUT}}$, $\overline{\text{DRDY}}$, $\overline{\text{HIT}}$, $\overline{\text{QREQ}}$, $\overline{\text{RSRV}}$.
6. Output valid time is measured from 2.4 to 0.8 V which may be longer than the time required to discharge from V_{DD} to 0.8 V.
7. According to the 60x bus protocol, $\overline{\text{ABB}}$ and $\overline{\text{DBB}}$ are driven only by the currently active bus master. They are asserted low then precharged high before returning to high-Z as shown in Figure 6. The nominal precharge width for $\overline{\text{ABB}}$ or $\overline{\text{DBB}}$ is 0.5 × t_{SYSCLK}, that is, less than the minimum t_{SYSCLK} period, to ensure that another master asserting $\overline{\text{ABB}}$, or $\overline{\text{DBB}}$ on the following clock will not contend with the precharge. Output valid and output hold timing is tested for the signal asserted. Output valid time is tested for precharge. The high-Z behavior is guaranteed by design.
8. According to the 60x bus protocol, $\overline{\text{ARTRY}}$ can be driven by multiple bus masters through the clock period immediately following $\overline{\text{AACK}}$. Bus contention is not an issue since any master asserting $\overline{\text{ARTRY}}$ will be driving it low. Any master asserting it low in the first clock following $\overline{\text{AACK}}$ will then go to high-Z for one clock before precharging it high during the second cycle after the assertion of $\overline{\text{AACK}}$. The nominal precharge width for $\overline{\text{ARTRY}}$ is 1.0 t_{SYSCLK}; that is, it should be high-Z as shown in Figure 6 before the first opportunity for another master to assert $\overline{\text{ARTRY}}$. Output valid and output hold timing are tested for the signal asserted. Output valid time is tested for precharge. The high-Z behavior is guaranteed by design.
9. Guaranteed by design and not tested.

Figure 4 provides the AC test load for the MPC7410.

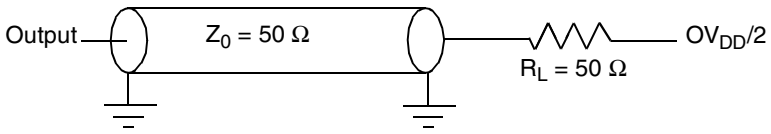

Figure 4. AC Test Load

Figure 5 provides the mode select input timing diagram for the MPC7410. The mode select inputs are sampled twice, once before and once after $\overline{\text{HRESET}}$ negation.

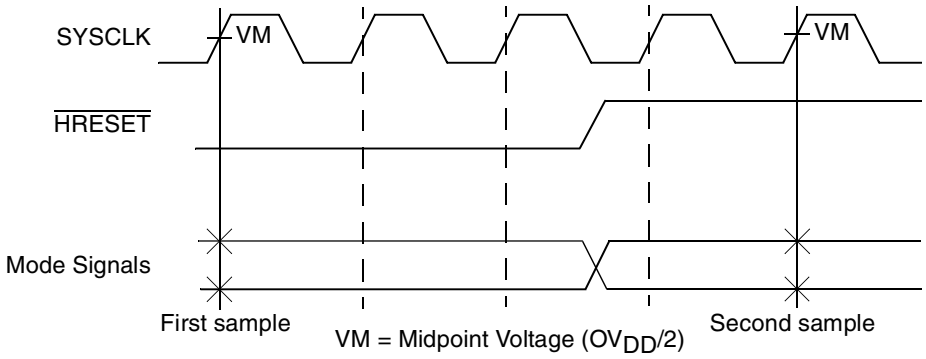

Figure 5. Mode Input Timing Diagram

Figure 6 provides the input/output timing diagram for the MPC7410.

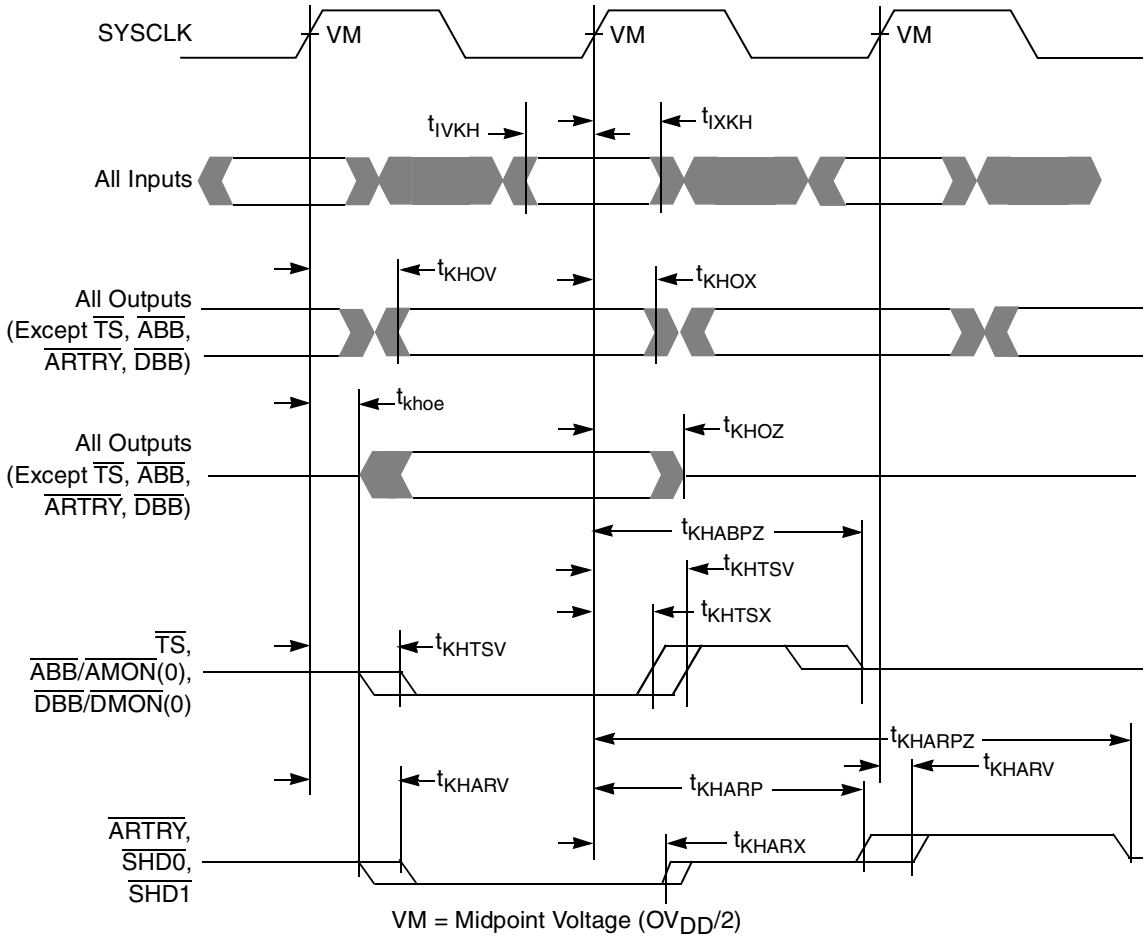

Figure 6. Input/Output Timing Diagram

4.2.4 L2 Bus AC Specifications

Table 10 provides the L2 bus interface AC timing specifications for the MPC7410 as defined in Figure 8 and Figure 9 for the loading conditions described in Figure 10.

Table 10. L2 Bus Interface AC Timing Specifications

At recommended operating conditions (see Table 3)

Parameter	Symbol	400, 450, 500 MHz		Unit	Notes
		Min	Max		
L2SYNC_IN rise and fall time	t_{L2CR} and t_{L2CF}	—	1.0	ns	1
Setup times: Data and parity	t_{DVL2CH}	1.5	—	ns	2
Input hold times: Data and parity	t_{DXL2CH}	—	0.0	ns	2
Valid times: All outputs when L2CR[14–15] = 00 All outputs when L2CR[14–15] = 01 All outputs when L2CR[14–15] = 10 All outputs when L2CR[14–15] = 11	t_{L2CHOV}	 — — — —	 2.5 2.5 2.9 3.5	ns	3, 4
Output hold times All outputs when L2CR[14–15] = 00 All outputs when L2CR[14–15] = 01 All outputs when L2CR[14–15] = 10 All outputs when L2CR[14–15] = 11	t_{L2CHOX}	 0.4 0.8 1.2 1.6	 — — — —	ns	3
L2SYNC_IN to high impedance: All outputs when L2CR[14–15] = 00 All outputs when L2CR[14–15] = 01 All outputs when L2CR[14–15] = 10 All outputs when L2CR[14–15] = 11	t_{L2CHOZ}	 — — — —	 2.0 2.5 3.0 3.5	ns	—

Notes:

1. Rise and fall times for the L2SYNC_IN input are measured from 20% to 80% of $L2OV_{DD}$.
2. All input specifications are measured from the midpoint of the signal in question to the midpoint voltage of the rising edge of the input L2SYNC_IN (see Figure 8). Input timings are measured at the pins.
3. All output specifications are measured from the midpoint voltage of the rising edge of L2SYNC_IN to the midpoint of the signal in question. The output timings are measured at the pins. All output timings assume a purely resistive 50-Ω load (see Figure 10).
4. The outputs are valid for both single-ended and differential L2CLK modes. For pipelined registered synchronous BurstRAMs, L2CR[14–15] = 00 is recommended. For pipelined late write synchronous BurstRAMs, L2CR[14–15] = 10 is recommended.

Table 11. JTAG AC Timing Specifications (Independent of SYSCLK) [1] (continued)

At recommended operating conditions (see Table 3)

Parameter	Symbol	Min	Max	Unit	Notes
$\overline{\text{TRST}}$ assert time	t_{TRST}	25	—	ns	2
Input setup times: Boundary-scan data TMS, TDI	 t_{DVJH} t_{IVJH}	 4 0	 — —	ns	3
Input hold times: Boundary-scan data TMS, TDI	 t_{DXJH} t_{IXJH}	 20 25	 — —	ns	3
Valid times: Boundary-scan data TDO	 t_{JLDV} t_{JLOV}	 4 4	 20 25	ns	4
TCK to output high impedance: Boundary-scan data TDO	 t_{JLDZ} t_{JLOZ}	 3 3	 19 9	ns	 4, 5 5

Notes:

1. All outputs are measured from the midpoint voltage of the falling/rising edge of TCLK to the midpoint of the signal in question. The output timings are measured at the pins. All output timings assume a purely resistive 50-Ω load (see Figure 11). Time-of-flight delays must be added for trace lengths, vias, and connectors in the system.
2. $\overline{\text{TRST}}$ is an asynchronous level sensitive signal. The setup time is for test purposes only.
3. Non-JTAG signal input timing with respect to TCK.
4. Non-JTAG signal output timing with respect to TCK.
5. Guaranteed by design and characterization.

Figure 11 provides the AC test load for TDO and the boundary-scan outputs of the MPC7410.

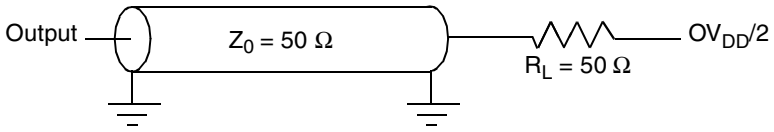

Figure 11. Alternate AC Test Load for the JTAG Interface

Figure 12 provides the JTAG clock input timing diagram.

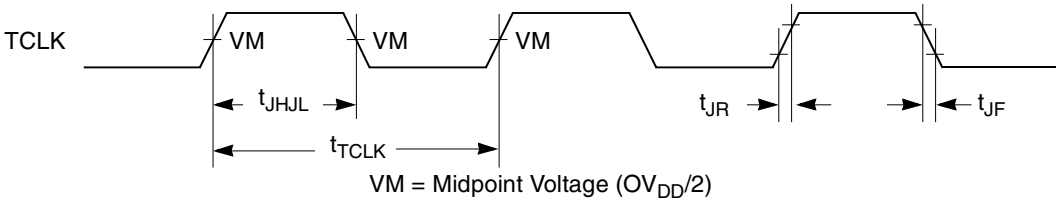

Figure 12. JTAG Clock Input Timing Diagram

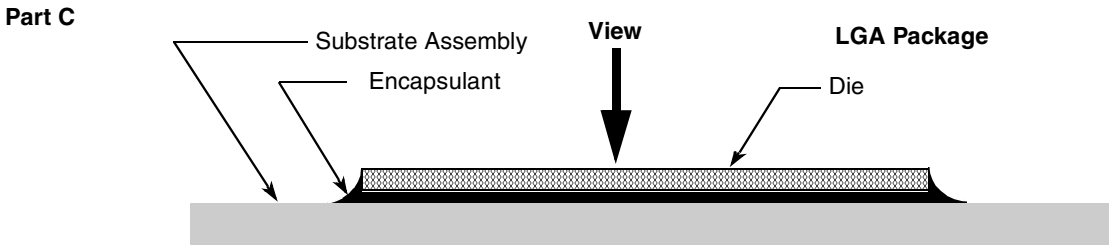

Figure 16. Pinout of the MPC7410, 360 CBGA and 360 HCTE Packages as Viewed from the Top Surface

6 Pinout Listings

Table 12 provides the pinout listing for the MPC7410 360 CBGA, 360 HCTE packages.

Table 12. Pinout Listing for the MPC7410, 360 CBGA and 360 HCTE Packages

Signal Name	Pin Number	Active	I/O	I/F Select [1]	Notes
A[0:31]	A13, D2, H11, C1, B13, F2, C13, E5, D13, G7, F12, G3, G6, H2, E2, L3, G5, L4, G4, J4, H7, E1, G2, F3, J7, M3, H3, J2, J6, K3, K2, L2	High	I/O	BVSEL	
$\overline{\text{AACK}}$	N3	Low	Input	BVSEL	—
$\overline{\text{ABB}}$	L7	Low	Output	BVSEL	12, 16
AP[0:3]	C4, C5, C6, C7	High	I/O	BVSEL	—
$\overline{\text{ARTRY}}$	L6	Low	I/O	BVSEL	—
AV_{DD}	A8	—	Input	V_{DD}	—
$\overline{\text{BG}}$	H1	Low	Input	BVSEL	—
$\overline{\text{BR}}$	E7	Low	Output	BVSEL	—
BVSEL	W1	High	Input	N/A	1, 3, 8, 9, 14
$\overline{\text{CHK}}$	K11	Low	Input	BVSEL	2, 8, 9
$\overline{\text{CI}}$	C2	Low	I/O	BVSEL	—
$\overline{\text{CKSTP\_IN}}$	B8	Low	Input	BVSEL	—
$\overline{\text{CKSTP\_OUT}}$	D7	Low	Output	BVSEL	—
CLK_OUT	E3	High	Output	BVSEL	—
$\overline{\text{DBB}}$	K5	Low	Output	BVSEL	12, 16
$\overline{\text{DBG}}$	K1	Low	Input	BVSEL	—
DH[0:31]	W12, W11, V11, T9, W10, U9, U10, M11, M9, P8, W7, P9, W9, R10, W6, V7, V6, U8, V9, T7, U7, R7, U6, W5, U5, W4, P7, V5, V4, W3, U4, R5	High	I/O	BVSEL	—

Table 12. Pinout Listing for the MPC7410, 360 CBGA and 360 HCTE Packages (continued)

Signal Name	Pin Number	Active	I/O	I/F Select [1]	Notes
V_{DD}	G8, G10, G12, J8, J10, J12, L8, L10, L12, N8, N10, N12	—	—	N/A	—

Notes:

1. OV_{DD} supplies power to the processor bus, JTAG, and all control signals except the L2 cache controls ($\overline{\text{L2CE}}$, $\overline{\text{L2WE}}$, and L2ZZ); $L2OV_{DD}$ supplies power to the L2 cache interface (L2ADDR[0:18], L2DATA[0:63], L2DP[0:7], and L2SYNC_OUT) and the L2 control signals; and V_{DD} supplies power to the processor core and the PLL and DLL (after filtering to become AV_{DD} and $L2AV_{DD}$, respectively). These columns serve as a reference for the nominal voltage supported on a given signal as selected by the BVSEL/L2VSEL pin configurations of Table 2 and the voltage supplied. For actual recommended value of V_{in} or supply voltages, see Table 3.
2. These are test signals for factory use only and must be pulled up to OV_{DD} for normal machine operation.
3. To allow for future I/O voltage changes, provide the option to connect BVSEL and L2VSEL independently to either OV_{DD}, GND, $\overline{\text{HRESET}}$, or ¬$\overline{\text{HRESET}}$. For the MPC7410 the L2 bus only supports 2.5- and 1.8-V options. The default selection, if L2VSEL is left unconnected, is 2.5-V operation. For the MPC7410 the processor bus supports 3.3-, 2.5-, and 1.8-V options. The default selection, if BVSEL is left unconnected, is 3.3-V operation. Refer to Table 2 for supported BVSEL and L2VSEL settings.
4. PLL_CFG[0:3] must remain stable during operation; should only be changed during the assertion of $\overline{\text{HRESET}}$ or during sleep mode and must adhere to the internal PLL-relock time requirement.
5. Ignored input in 60x bus mode.
6. Unused output in 60x bus mode. Signal is three-stated in 60x mode.
7. Deasserted (pulled high) at $\overline{\text{HRESET}}$ negation for 60x bus mode. Asserted (pulled low) at $\overline{\text{HRESET}}$ negation for MPX bus mode.
8. Uses one of nine existing no connects in the MPC750 360 BGA package.
9. Internal pull up on die. Pulled-up signals are V_{DD} based.
10. Reuses MPC750 $\overline{\text{DRTRY}}$, $\overline{\text{DBDIS}}$, and TLBISYNC pins (DTI1, DTI2, and $\overline{\text{EMODE}}$, respectively).
11. The VOLTDET pin position on the MPC750 360 BGA package is now an $L2OV_{DD}$ pin on the MPC7410 360 package.
12. Output only for MPC7410, was I/O for MPC750.
13. MPX bus mode only.
14. If necessary, to overcome the internal pull-up resistance and ensure this input will recognize a low signal, a pull-down resistance less than 250 Ω should be used.
15. $\overline{\text{MCP}}$ minimum pulse width: asynchronous, falling-edge input needs to be held asserted for a minimum of 2 cycles to guarantee that it is latched by the processor.
16. In MPX bus mode the $\overline{\text{ABB}}$ signal is called $\overline{\text{AMON}}$ and the $\overline{\text{DBB}}$ signal is called $\overline{\text{DMON}}$. These signals are not a requirement of the MPX bus protocol and may not be available on future products.

7 Package Description

The following sections provide the package parameters and mechanical dimensions for the MPC7410, 360 CBGA and 360 HCTE packages.

7.1 Package Parameters for the MPC7410, 360 CBGA and 360 HCTE_CBGA

The package parameters are as provided in the following list. The package types are the 25 × 25 mm, 360-lead ceramic ball grid array package (CBGA) or the 25 × 25 mm, 360-lead high coefficient of thermal expansion CBGA package (HCTE_CBGA).

Package outline	25 × 25 mm
Interconnects	360 (19 × 19 ball array – 1)
Pitch	1.27 mm (50 mil)
Minimum module height	2.72 mm
Maximum module height	3.20 mm
Ball diameter	0.89 mm (35 mil)
Coefficient of thermal expansion	6.8 ppm/°C (CBGA) 12.3ppm/°C (HCTE_CBGA)

7.2 Package Parameters for the MPC7410, 360 HCTE_CBGA (Lead Free C5 Spheres)

The package parameters are as listed here. The package types are the 25 × 25 mm, 360-lead high coefficient of thermal expansion CBGA package with lead-free C5 spheres (HCTE_CBGA lead-free spheres).

Package outline	25 × 25 mm
Interconnects	360 (19 × 19 ball array – 1)
Pitch	1.27 mm (50 mil)
Minimum module height	2.32 mm
Maximum module height	2.80 mm
Ball diameter	0.76 mm (30 mil)
Coefficient of thermal expansion	12.3ppm/°C

MPC7410 core, and the phase adjustment range that the L2 DLL supports. Table 14 shows various example L2 clock frequencies that can be obtained for a given set of core frequencies. The minimum L2 frequency target is 133 MHz. Sample core-to-L2 frequencies for the MPC7410 is shown in Table 14. In this example, shaded cells represent settings that, for a given core frequency, result in L2 frequencies that do not comply with the minimum and maximum L2 frequencies listed in Table 10.

Table 14. Sample Core-to-L2 Frequencies

Core Frequency (MHz)	÷1	÷1.5	÷2	÷2.5	÷3	÷3.5	÷4
350	350	233	175	140	—	—	—
366	366	244	183	147	—	—	—
400	400	266	200	160	133	—	—
433	—	288	216	173	144	—	—
450	—	300	225	180	150	—	—
466	—	311	233	186	155	133	—
500	—	333	250	200	166	143	—

Note: The core and L2 frequencies are for reference only. Some examples may represent core or L2 frequencies which are not useful, not supported, or not tested for by the MPC7410; see Section 4.2.3, "L2 Clock AC Specifications," for valid L2CLK frequencies. The L2CR[L2SL] bit should be set for L2CLK frequencies less than 150 MHz.

8.2 PLL and DLL Power Supply Filtering

The AV_{DD} and $L2AV_{DD}$ power signals are provided on the MPC7410 to supply power to the PLL and DLL, respectively. Both AV_{DD} and $L2AV_{DD}$ can be supplied power from the V_{DD} power plane. High frequency noise in the 500 kHz to 10 MHz resonant frequency range of the PLL on the V_{DD} power plane could affect the stability of the internal clocks.

On systems that use the MPC7410 HCTE device, the AV_{DD} and $L2AV_{DD}$ input signals should both implement the circuit shown in Figure 21.

On systems that use the MPC7410 CBGA device, the $L2AV_{DD}$ input should implement the circuit shown in Figure 21.

When selecting which filter to use on the AV_{DD} input of the MPC7410 CBGA device specifically, system designers should refer to Erratum No. 18 in the *MPC7410 RISC Microprocessor Chip Errata* (MPC7410CE). The AV_{DD} input of the MPC7410 CBGA device is sensitive to system noise on both the V_{DD} power plane, as described above, and the OV_{DD} power plane as described in the Erratum No. 18. With these AV_{DD} sensitivities to OV_{DD} and V_{DD} noise, care must be taken when selecting the filter circuit for the AV_{DD} input of the MPC7410 CBGA device. Erratum No. 18 does not apply to the AV_{DD} input of the MPC7401 HCTE device, nor does it affect the $L2AV_{DD}$ input of either the HCTE or the CBGA device.

As described in Erratum No. 18, when there is a high amount of noise on the OV_{DD} power plane due to I/O switching rates, it is possible for the OV_{DD} noise to couple into the PLL supply voltage (AV_{DD}) internal to the MPC7410 CBGA package. It is the recommendation of Freescale, that new designs using the MPC7410 CBGA package provide the ability to implement either filter shown in Figure 21 and Figure 22 at the AV_{DD} input. Existing designs that implemented Figure 21 on AV_{DD} may never experience the error described in Erratum No. 18. Both new and

existing designs should qualify both AV_{DD} filter solutions, and the filter providing the most robust margin should be implemented.

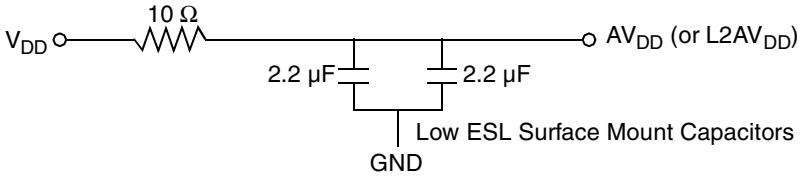

Figure 21. PLL Power Supply Filter Circuit No.1

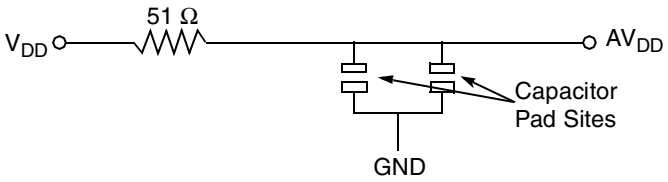

Figure 22. PLL Power Supply Filter Circuit No. 2

The filter circuit should be placed as close as possible to the AV_{DD} pin to minimize noise coupled from nearby circuits. A separate circuit should be placed as close as possible to the $L2AV_{DD}$ pin. It is often possible to route directly from the capacitors to the AV_{DD} pin, which is on the periphery of the 360 BGA footprint, without the inductance of vias. The $L2AV_{DD}$ pin may be more difficult to route, but is proportionately less critical.

It is the recommendation of Freescale, that systems that implement the AV_{DD} filter shown in Figure 22 design in the pads for the removed capacitors (shown in Figure 21), to provide for the possible reintroduction of the filter in Figure 21. This would be necessary in case there is a planned transition from the CBGA package to the HCTE package of the MPC7410.

8.3 Decoupling Recommendations

Due to the MPC7410 dynamic power management feature, large address and data buses, and high operating frequencies, the MPC7410 can generate transient power surges and high frequency noise in its power supply, especially while driving large capacitive loads. This noise must be prevented from reaching other components in the MPC7410 system, and the MPC7410 itself requires a clean, tightly regulated source of power. Therefore, it is recommended that the system designer place at least one decoupling capacitor at each V_{DD}, OV_{DD}, and $L2OV_{DD}$ pin of the MPC7410. It is also recommended that these decoupling capacitors receive their power from separate V_{DD}, $(L2)OV_{DD}$, and GND power planes in the PCB, utilizing short traces to minimize inductance.

These capacitors should have a value of 0.01 or 0.1 µF. Only ceramic SMT (surface mount technology) capacitors should be used to minimize lead inductance, preferably 0508 or 0603 orientations, where connections are made along the length of the part.

In addition, it is recommended that there be several bulk storage capacitors distributed around the PCB, feeding the V_{DD}, $L2OV_{DD}$, and OV_{DD} planes, to enable quick recharging of the smaller chip capacitors. These bulk capacitors should have a low ESR (equivalent series resistance) rating to ensure the quick response time necessary. They should also be connected to the power and ground planes through two vias to minimize inductance. Suggested bulk capacitors—100–330 µF (AVX TPS tantalum or Sanyo OSCON).

8.4 Connection Recommendations

To ensure reliable operation, it is highly recommended to connect unused inputs to an appropriate signal level through a resistor. Unused active low inputs should be tied to OV_{DD}. Unused active high inputs should be connected to GND. All NC (no connect) signals must remain unconnected.

Power and ground connections must be made to all external V_{DD}, OV_{DD}, $L2OV_{DD}$, and GND pins of the MPC7410. Note that power must be supplied to $L2OV_{DD}$ even if the L2 interface of the MPC7410 will not be used; the remainder of the L2 interface may be left unterminated.

8.5 Output Buffer DC Impedance

The MPC7410 60x and L2 I/O drivers are characterized over process, voltage, and temperature. To measure Z_0, an external resistor is connected from the chip pad to OV_{DD} or GND. Then, the value of each resistor is varied until the pad voltage is $OV_{DD}/2$ (see Figure 23).

The output impedance is the average of two components, the resistances of the pull-up and pull-down devices. When data is held low, SW2 is closed (SW1 is open), and R_N is trimmed until the voltage at the pad equals $(L2)OV_{DD}/2$. R_N then becomes the resistance of the pull-down devices. When data is held high, SW1 is closed (SW2 is open), and R_P is trimmed until the voltage at the pad equals $(L2)OV_{DD}/2$. R_P then becomes the resistance of the pull-up devices. R_P and R_N are designed to be close to each other in value. Then, $Z_0 = (R_P + R_N)/2$.

Figure 23 describes the driver impedance measurement circuit described above.

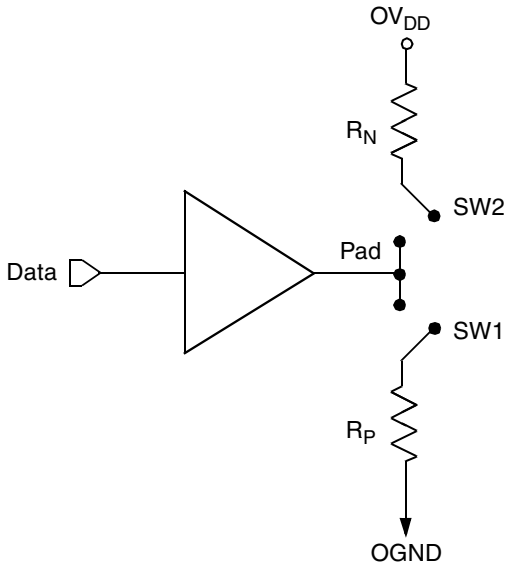

Figure 23. Driver Impedance Measurement Circuit

Alternately, the following is another method to determine the output impedance of the MPC7410. A voltage source, V_{force}, is connected to the output of the MPC7410, as in Figure 24. Data is held low, the voltage source is set to a value that is equal to $(L2)OV_{DD}/2$, and the current sourced by V_{force} is measured. The voltage drop across the pull-down device, which is equal to $(L2)OV_{DD}/2$, is divided by the measured current to determine the output impedance of the pull-down device, R_N. Similarly, the impedance of the pull-up device is determined by dividing the voltage drop of the pull-up, $(L2)OV_{DD}/2$, by the current sank by the pull-up when the data is high and V_{force} is equal to $(L2)OV_{DD}/2$. This method can be employed with either empirical data from a test setup or with data from simulation models, such as IBIS.

The COP interface has a standard header for connection to the target system, based on the 0.025" square-post 0.100" centered header assembly (often called a Berg header). The connector typically has pin 14 removed as a connector key.

There is no standardized way to number the COP header shown in Figure 25; consequently, many different pin numbers have been observed from emulator vendors. Some are numbered top-to-bottom then left-to-right, while others use left-to-right then top-to-bottom, while still others number the pins counter clockwise from pin 1 (as with an IC). Regardless of the numbering, the signal placement recommended in Figure 25 is common to all known emulators.

The $\overline{\text{QACK}}$ signal shown in Figure 25 is usually connected to the PCI bridge chip in a system and is an input to the MPC7410 informing it that it can go into the quiescent state. Under normal operation this occurs during a low-power mode selection. In order for COP to work, the MPC7410 must see this signal asserted (pulled down). While shown on the COP header, not all emulator products drive this signal. If the product does not, a pull-down resistor can be populated to assert this signal. Additionally, some emulator products implement open-drain type outputs and can only drive $\overline{\text{QACK}}$ asserted; for these tools, a pull-up resistor can be implemented to ensure this signal is negated when it is not being driven by the tool. Note that the pull-up and pull-down resistors on the $\overline{\text{QACK}}$ signal are mutually exclusive and it is never necessary to populate both in a system. To preserve correct power-down operation, $\overline{\text{QACK}}$ should be merged via logic so that it also can be driven by the PCI bridge.

8.8 Thermal Management Information

This section provides thermal management information for the MPC7410 for air-cooled applications. Proper thermal control design is primarily dependent on the system-level design—the heat sink, airflow, and thermal interface material. To reduce the die-junction temperature, heat sinks may be attached to the package by several methods such as spring clip to holes in the printed circuit board or with screws and springs to the printed circuit board; see Figure 26 for the BGA package and Figure 27 for the LGA package. This spring force should not exceed 5.5 pounds of force. Note that care should be taken to avoid focused forces being applied to die corners and/or edges when mounting heat sinks.

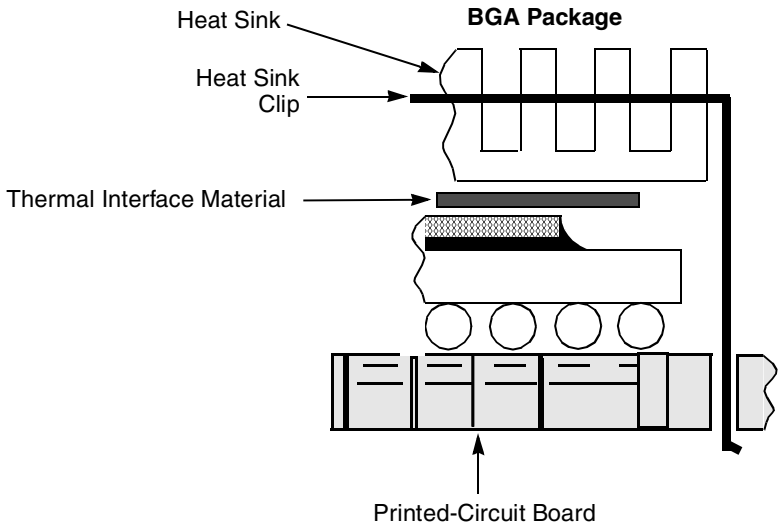

Figure 26. BGA Package Exploded Cross-Sectional View with Heat Sink Clip to PCB Option

9 Document Revision History

Table 16 provides a revision history for this hardware specification.

Table 16. Document Revision History

Revision	Date	Substantive Change(s)
6.1	11/16/2007	Updated Table 17 and Table 19 to show the VU package is available as an MC prefix device compared to an MPC prefix for the other package types; this was done to match the specification documents with the device ordering and part marking information. Updated title of Table 19 to reflect correct name of referenced document and updated respective document order information below table. Updated notes in Table 1–Table 3 replacing references to MPC7410RX*nnn*LE with M*xx*7410*xxnnn*LE since notes to apply to all the available packages types.
6	8/14/2007	Updated Table 4 thermal information: • Deleted rows on single-layer (1s) boards. • CBGA package $R_{\theta JMA}$ for natural convection for four layer boards changed from 17 to 18 °C/W. • HCTE package $R_{\theta JMA}$ for natural convection for four layer boards changed from 22 to 20 °C/W. • HCTE package $R_{\theta JMA}$ for 200 ft./min airflow for four layer boards changed from 19 to 16 °C/W with airflow rate specification changed from 200 ft./min to 1 m/sec. • HCTE package $R_{\theta JMA}$ for 400 ft./min airflow for four layer boards changed from 18 to 15 °C/W with airflow rate specification changed from 400 ft./min to 2 m/sec. • CBGA package $R_{\theta JB}$ changed from 8 to 9°C/W. • HCTE package $R_{\theta JB}$ changed from 14 to 11°C/W. • Table 4 Notes 2 - 4 have been revised and updated; Note 5 is no longer used. Notes on table rows have been renumbered. Updated Figure 26 removing optional heat sink clip to package. Removed references in document to adhesive attached thermal solutions. Updated thermal solution vendor information in Section 8.8. Added HCTE_CBGA Lead Free C5 Spheres (VU) packaging information to document: • Added Section 7.2, “Package Parameters for the MPC7410, 360 HCTE_CBGA (Lead Free C5 Spheres). • Added Figure 18 for HCTE_CBGA Lead Free C5 Spheres package, similar to Figure 17 but with differences in dimensions A, A1, and b in the figure’s dimension table. • Added HCTE_CBGA Lead Free C5 Spheres (VU) packaging information in Table 17 and Table 19. • Changed part marking example in Figure 31 to an HCTE_CBGA device.

Table 16. Document Revision History (continued)

Revision	Date	Substantive Change(s)
1.1	—	Internal release.
		Table 12—added note 16 for $\overline{\text{ABB}}$/$\overline{\text{AMON}}$ and $\overline{\text{DBB}}$/$\overline{\text{DMON}}$ signal clarification.
		Table 12—changed $\overline{\text{CHK}}$ note 4 reference to note 2, signal is for factory test only. Changed previous note 4 ($\overline{\text{CHK}}$ related) to now provide additional PLL info.
		Table 1—modified maximum value for OV_{DD} from –0.3 to 3.465 to now be –0.3 to 3.6 and $L2OV_{DD}$ from –0.3 to 2.6 to now be –0.3 to 2.8. Modified note 6, OV_{DD} for revisions prior to Rev. 1.4 have maximum value for OV_{DD} of –0.3 to 2.8.
		Table 8—removed note 12. L2_TSTCLK is for factory use only (see Table 12, note 2).
		Section 1.10.2—revised section to include nomenclature tables for part markings not covered by this spec.
		Figure 2—added that under/overshoot for $L2OV_{DD}$ references t_{L2CLK} while OV_{DD} references t_{SYSCLK}.
		Table 4—added HCTE package (HX package descriptor) thermal characteristics.
		Section 1.5—added HCTE package (HX package descriptor). Both the CBGA and HCTE packages have the same pin assignments.
		Section 1.6—added HCTE package (HX package descriptor). Both the CBGA and HCTE packages have the same pinout listings.
		Section 1.7—added HCTE package (HX package descriptor). Both the CBGA and HCTE packages have the same package parameters and dimensions.
		Table 17—added HCTE package (HX package descriptor) to part numbering nomenclature.
		Table 21—added MPC7410THXnnnLE extended temperature HCTE package part numbers and part number specification document reference.

Table 16. Document Revision History (continued)

Revision	Date	Substantive Change(s)
1.0	—	Section 1.3 and Table 3—revised OV_{DD} from 3.3 V ± 100 mV to 3.3 V ± 165 mV.
		Table 13—removed unsupported PLL configurations.
		Table 12—added note 15 for minimum $\overline{MCP}$ pulse width, correct note 3 for 3.3-V processor bus support.
		Table 13—revised note 3 to include emulator tool development.
		Table 14—removed unsupported Core-to-L2 example frequencies.
		Section 1.8.8—updated heat sink vendors list.
		Section 1.8.8.2—updated interface vendors list.
		Table 1—updated voltage sequencing requirements notes 3 and 4.
		Table 4—Updated/added thermal characteristics.
		Table 5—removed table and TAU related information, TAU is no longer supported.
		Table 6—updated I_{in} and I_{TSI} leakage current specs.
		Section 1.8.3—removed section.
		Section 1.10—reformatted section.
		Section 1.8.6—changed recommended pull-up resistor value to 1 kW–5 kW. Added $\overline{AACK}$, $\overline{TEA}$, and $\overline{TS}$ to control signals needing pull-ups. Added pull-up resistor value recommendation for L1_TSTCLK, L2_TSTCLK, and $\overline{LSSD\_MODE}$ factory test signals.
		Section 1.8.7—revised text regarding connection of $\overline{TRST}$. Combined Figure 22, Figure 23, and Table 17, into Figure 21.
		Table 7—corrected min VCO frequencies from 450 to 700 MHz to match min processor frequency of 350 MHz.
		Table 2—added note 3 to clarify BVSEL for revisions prior to Rev. E which do not support 3.3 V OV_{DD}.
		Table 3—added notes 5 and 6 to clarify BVSEL for revisions prior to Rev. E which do not support 3.3 V OV_{DD}.
		Table 5—added note 8 regarding DC voltage limits for JTAG signals.

10 Ordering Information

Ordering information for the parts fully covered by this specification document is provided in Section 10.1, “Part Numbers Addressed by This Specification.” Section 10.2, “Part Numbers Not Fully Addressed by This Document,” lists the part numbers which do not fully conform to the specifications of this document. These special part numbers require an additional document called a part number specification.

10.1 Part Numbers Addressed by This Specification

Table 17 provides the Freescale part numbering nomenclature for the MPC7410 Note that the individual part numbers correspond to a maximum processor core frequency. For available frequencies, contact your local Freescale sales office. In addition to the processor frequency, the part numbering scheme also includes an application modifier which may specify special application conditions. Each part number also contains a revision code which refers to the die mask revision number.

Table 17. Part Numbering Nomenclature

Mxx	**7410**	***xx***	***nnn***	***x***	***x***
Product Code	**Part Identifier**	**Package [1]**	**Processor Frequency [2]**	**Application Modifier**	**Revision Level**
MPC	7410	RX = CBGA	400 450 500	L: 1.8 V ± 100 mV 0° to 105°C	C: 1.2; PVR = 800C 1102 D: 1.3; PVR = 800C 1103 E: 1.4; PVR = 800C 1104
		HX = HCTE_CBGA			E: 1.4; PVR = 800C 1104
		VS = HCTE_LGA			
MC		VU = HCTE_CBGA (Lead Free C5 Solder Spheres)	400 500		

Notes:

1. See Section 7, “Package Description,” for more information on available package types and Table 4 for more information on thermal characteristics.
2. Processor core frequencies supported by parts addressed by this specification only. Not all parts described in this specification support all core frequencies. Additionally, parts addressed by part number specifications may support other maximum core frequencies.